Se	arch Notes	

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/676,535	IKEBE ET AL.	
Examiner	Art Unit	
Yuzhen Ge	2624	

SEARCHED			
Class	Subclass	Date	Examiner
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INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
EAST (USPAT, US-PUPUB, EPO, JPO, DERWENT, IBM_TDB, USOCR) - See search history printout	1/26/2007	YG
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